

规格书

SPECIFICATION FOR APPROVAL

产品名称： 汽车级多层片式瓷介电容器

产品规格： 全系列

制作	核准	审核
詹熔基	莫茵	方齐炜

供应商：深圳市美隆电子有限公司

地址：深圳市福田区华强北路华强广场 A 座 16 楼

TEL: 0755-82533555

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1.摘要 Resume >>>

- 产品尺寸精度高，便于自动贴片机高效装配
- The precision of product size is high,suitable for auto SMT machines high efficiency assembly.
- 端电极三层电极，适合波峰焊与回流焊；介电体与外表为同种材料，环境条件影响小
- External Electrode has 3 layers,suitable for both wave and reflow soldering.
- 符合 AEC-Q200
- AEC-Q200 Compliance

2.电容器及介质分类 Types of Capacitor and Dielectric Material>>>

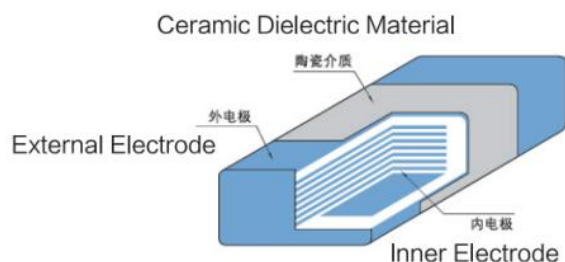
●COG：此类介质材料的电容器为 I 类电容器，包括常规、中高压 COG 产品。此类产品电性能稳定，几乎不随温度、电压和时间的变化而变化。适用于低损耗，稳定性要求高的电路中，如滤波器、谐振器和计时电路中。

●COG：The capacitor of this kind dielectric material is considered as Class I capacitor, including general capacitor and high frequency COG capacitor. The electrical properties of COG capacitor are the most stable one and have little change with temperature, voltage and time. They are suited for applications where low-losses and high-stability are required, such as filters, oscillators, and timing circuits.

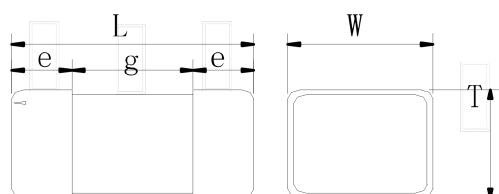
●X7R/X7S/X7T/X5R/X6R/X6S/X6T：此类介质材料的电容器为 II 类电容器，具有较高的介电常数，容量比 I 类电容器高，具有较稳定的温度特性，适用于容量范围广，稳定性要求不高的电路中，如隔直、耦合、旁路、鉴频等电路中。

●X7R/X7S/X7T/X5R/X6R/X6S/X6T：material is a kind of material has high dielectric constant. The capacitor made of this kind material is considered as Class II capacitor whose capacitance is higher than that of class I. These capacitors are classified as having a semi-stable temperature characteristic and used over a wide temperature range, such in these kinds of circuits, DC-blocking, decoupling, bypassing, frequency discriminating etc.

3.结构图 Construction >>>



4.尺寸 Dimensions >>>



Type	L (mm)	W(mm)	e (mm)	g	T (mm)				
0201	0.60±0.03	0.30±0.03	0.1~0.2	0.2	0.30±0.03	---	---	---	---
0201 ^{*2}	0.60-0.03/+0.1	0.30-0.03/+0.1	0.1~0.2	0.2	0.30-0.03/+0.1	---	---	---	---
0402	1.00±0.10	0.50±0.10	0.15~0.3	0.4	0.50±0.10	---	---	---	---
0402 ^{*2}	1.00-0.05/+0.2	0.50-0.05/+0.2	0.15~0.3	0.4	0.50-0.05/+0.2	---	---	---	---
0603	1.60±0.10	0.80±0.10	0.2~0.6	0.5	0.80±0.10	---	---	---	---
0603 ^{*1}	1.60±0.20 ^{*1}	0.80±0.20 ^{*1}	0.2~0.6	0.5	0.80±0.20 ^{*1}	---	---	---	---
0603 ^{*3}	1.60-0/+0.3	0.80-0/+0.3	0.2~0.6	0.5	0.80-0/+0.3	---	---	---	---
0805	2.00±0.10	1.25±0.10	0.2~0.7	0.7	0.60±0.10	0.85±0.10	1.25±0.20	---	---
0805 ^{*1}	2.00±0.20 ^{*1}	1.25±0.20 ^{*1}	0.2~0.7	0.7	0.60±0.10	0.85±0.20	1.25±0.20	---	---
1206	3.20±0.20	1.60±0.20	0.3~0.8	1.6	0.85±0.10	1.00±0.10	1.25±0.20	1.60±0.20	---
1206 ^{*1}	3.20±0.30 ^{*1}	1.60±0.30 ^{*1}	0.3~0.8	1.6	0.85±0.10	1.00±0.10	1.25±0.20	1.60±0.30 ^{*1}	---
1210	3.20±0.30	2.5±0.20	0.3~0.8	1.6	0.85±0.10	1.25±0.20	1.60±0.20	2.00±0.20	2.50±0.30
1210 ^{*1}	3.20±0.40 ^{*1}	2.5±0.30 ^{*1}	0.3~0.8	1.6	0.85±0.10	1.25±0.20	1.60±0.30	2.00±0.30	---
1812	4.50±0.30	3.2±0.30	0.3~1.5	2.5	1.25±0.20	1.60±0.20	2.00±0.20	2.50±0.30	---
1812 ^{*1}	4.50±0.40 ^{*1}	3.2±0.40 ^{*1}	0.3~1.5	2.5	1.25±0.20	1.60±0.20	2.00±0.20	2.50±0.30	---
2220	5.70±0.40	5.0±0.40	0.3~1.1	3.5	1.25±0.20	1.60±0.20	2.00±0.20	2.50±0.30	---

^{*1} 标识该规格型号标识为 1uF 及以上规格产品尺寸。

^{*2} 标识该规格型号标识为 100nF 及以上规格产品尺寸。

^{*3} 标识该规格型号标识为 10uF 及以上规格产品尺寸。

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5.型号名称 Part Numbering >>>

AC	0603	X7R	102	K	500	N	T	D	D
产品类型 Product Type	尺寸 Size	材质 Texture	电容值 Capacitance	允许偏差 Tolerance	额定电压 Rate Voltage	端头类型 Terminal Type	包装 Packaging	厚度 Thickness	数量代码 Quantity code
汽车级多层片式瓷介电容器	0201	C0G	1R5=1.5pF 100=10pF 102=1nF 222=2.2nF 105=1uF	A=±0.05pF	6R3=6.3VDC	N: Cu/Ni/Sn N=铜/镍/锡	B: 袋散装 B: bulk packaging in a bag T: 编带 T: tape carrier packaging	A:0.3±0.03mm	A=1Kpcs
	0402	X7R		B=±0.1pF	100=10VDC			B:0.50±0.10mm	B=2Kpcs
	0603	X7S		C=±0.25pF	160=16VDC			E:0.60±0.10mm	C=3Kpcs
	0805	X7T		D=±0.5pF	250=25VDC			D:0.80±0.10mm	D=4Kpcs
	1206	X5R		F=±1.0%	500=50VDC			F:0.85±0.10mm	E=5Kpcs
	1210	X6S		G=±2.0%	101=100VDC			G:1.00±0.10mm	F=10Kpcs
	1812	X6R		J=±5.0%	201=200VDC			H:1.25±0.20mm	G=15Kpcs
	2220	X6T		K=±10%	251=250VDC			L:1.6±0.20mm	H=50Kpcs
				M=±20%	501=500VDC			Q:2.0±0.20mm	I=20Kpcs
					631=630VDC			R:2.5±0.30mm	J=0.7Kpcs
					102=1000VDC				K=0.5Kpcs
					202=2000VDC				L=1.5Kpcs

产品的介质特性组别

材质	工作温度范围	温度系数或温度特性
C0G	-55℃~+125℃	0±30ppm/℃
X7R	-55℃~+125℃	±15%
X7S	-55℃~+125℃	±22%
X7T	-55℃~+125℃	+22/-33%
X6R	-55℃~+105℃	±15%
X6S	-55℃~+105℃	±22%
X6T	-55℃~+105℃	+22/-33%
X5R	-55℃~+85℃	±15%

6.产品容值范围 Product Capacitance Range>>>

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0201 (0603)																																									
	COG系列					X7R系列					X7S系列					X7T系列					X6R系列					X6S系列					X6T系列					X5R系列					
Cp/V	50	25	16	10	6.3	50	25	16	10	6.3	50	25	16	10	6.3	50	25	16	10	6.3	50	25	16	10	6.3	50	25	16	10	6.3	50	25	16	10	6.3	50	25	16	10	6.3	
271						*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*
331						*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*
471						*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*
681						*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*
751						*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*
102						*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*
152						*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*
222						*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*
332						*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*
472						*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*
682						*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*
103							*	*	*	*		*	*	*	*		*	*	*	*		*	*	*	*			*	*	*	*		*	*	*	*	*	*	*	*	*
153								*	*	*			*	*	*		*	*	*	*		*	*	*	*			*	*	*	*			*	*	*	*	*	*	*	*
223								*	*	*			*	*	*			*	*	*		*	*	*	*			*	*	*	*			*	*	*	*	*	*	*	*
473								*	*	*			*	*	*				*	*			*	*	*				*	*	*				*	*	*	*	*	*	
863										*	*			*	*				*	*			*	*	*				*	*	*				*	*	*	*	*	*	
104														*				*							*					*									*		
224																																							*		
474																																									
105																																									

0402（1005）																																					
	COG系列					X7R系列					X7S系列					X7T系列					X6R系列					X6S系列					X5R系列						
Cp/V	50	25	16	10	6.3	50	25	16	10	6.3	50	25	16	10	6.3	50	25	16	10	6.3	50	25	16	10	6.3	50	25	16	10	6.3	50	25	16	10	6.3		
0R1	*	*	*	*	*																																
0R2	*	*	*	*	*																																
0R3	*	*	*	*	*																																
0R4	*	*	*	*	*																																
0R5	*	*	*	*	*																																
0R6	*	*	*	*	*																																
0R7	*	*	*	*	*																																
0R8	*	*	*	*	*																																
0R9	*	*	*	*	*																																
1R0	*	*	*	*	*																																
1R1	*	*	*	*	*																																
1R2	*	*	*	*	*																																
1R3	*	*	*	*	*																																
1R5	*	*	*	*	*																																
1R6	*	*	*	*	*																																
1R8	*	*	*	*	*																																
2R0	*	*	*	*	*																																
2R2	*	*	*	*	*																																
2R4	*	*	*	*	*																																
2R7	*	*	*	*	*																																

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0603 (1608)																																																		
	COG系列						X7R系列						X7S系列						X7T系列						X6R系列						X6S系列						X6T系列						X5R系列							
Cp/V	500	250	200	100	50	25	250	100	50	25	16	10	6.3	250	100	50	25	16	10	6.3	250	100	50	25	16	10	6.3	250	100	50	25	16	10	6.3	250	100	50	25	16	10	6.3	250	100	50	25	16	10	6.3		
153							*	*	*	*	*	*	*		*	*	*	*	*	*		*	*	*	*	*	*		*	*	*	*	*	*	*		*	*	*	*	*	*		*	*	*	*	*	*	*
183							*	*	*	*	*	*	*		*	*	*	*	*	*		*	*	*	*	*	*		*	*	*	*	*	*	*		*	*	*	*	*	*		*	*	*	*	*	*	*
223							*	*	*	*	*	*	*		*	*	*	*	*	*		*	*	*	*	*	*		*	*	*	*	*	*	*		*	*	*	*	*	*		*	*	*	*	*	*	*
273							*	*	*	*	*	*	*		*	*	*	*	*	*		*	*	*	*	*	*		*	*	*	*	*	*	*		*	*	*	*	*	*		*	*	*	*	*	*	*
333							*	*	*	*	*	*	*		*	*	*	*	*	*		*	*	*	*	*	*		*	*	*	*	*	*	*		*	*	*	*	*	*		*	*	*	*	*	*	*
393							*	*	*	*	*	*	*		*	*	*	*	*	*		*	*	*	*	*	*		*	*	*	*	*	*	*		*	*	*	*	*	*		*	*	*	*	*	*	*
473							*	*	*	*	*	*	*		*	*	*	*	*	*		*	*	*	*	*	*		*	*	*	*	*	*	*		*	*	*	*	*	*		*	*	*	*	*	*	*
563							*	*	*	*	*	*	*		*	*	*	*	*	*		*	*	*	*	*	*		*	*	*	*	*	*	*		*	*	*	*	*	*		*	*	*	*	*	*	*
683							*	*	*	*	*	*	*		*	*	*	*	*	*		*	*	*	*	*	*		*	*	*	*	*	*	*		*	*	*	*	*	*		*	*	*	*	*	*	*
104							*	*	*	*	*	*	*		*	*	*	*	*	*		*	*	*	*	*	*		*	*	*	*	*	*	*		*	*	*	*	*	*		*	*	*	*	*	*	*
154							*	*	*	*	*	*	*		*	*	*	*	*	*		*	*	*	*	*	*		*	*	*	*	*	*	*		*	*	*	*	*	*		*	*	*	*	*	*	*
184							*	*	*	*	*	*	*		*	*	*	*	*	*		*	*	*	*	*	*		*	*	*	*	*	*	*		*	*	*	*	*	*		*	*	*	*	*	*	*
224							*	*	*	*	*	*	*		*	*	*	*	*	*		*	*	*	*	*	*		*	*	*	*	*	*	*		*	*	*	*	*	*		*	*	*	*	*	*	*
274							*	*	*	*	*	*	*		*	*	*	*	*	*		*	*	*	*	*	*		*	*	*	*	*	*	*		*	*	*	*	*	*		*	*	*	*	*	*	*
334							*	*	*	*	*	*	*		*	*	*	*	*	*		*	*	*	*	*	*		*	*	*	*	*	*	*		*	*	*	*	*	*		*	*	*	*	*	*	*
474							*	*	*	*	*	*	*		*	*	*	*	*	*		*	*	*	*	*	*		*	*	*	*	*	*	*		*	*	*	*	*	*		*	*	*	*	*	*	*
684							*	*	*	*	*	*	*		*	*	*	*	*	*		*	*	*	*	*	*		*	*	*	*	*	*	*		*	*	*	*	*	*		*	*	*	*	*	*	*
105								*	*	*	*	*	*					*	*	*					*	*	*					*	*	*	*		*	*	*	*	*	*					*	*	*	*
225									*	*	*	*	*					*	*	*					*	*	*					*	*	*	*		*	*	*	*	*	*					*	*	*	*
475										*	*	*	*						*	*					*	*	*						*	*	*					*	*	*					*	*	*	*
106																			*	*					*	*	*							*	*						*	*					*	*	*	*
226																			*	*					*	*	*								*	*							*	*					*	*

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1206 (3216)																																													
	COG系列									X7R系列										X7S系列										X7T系列															
Cp/V _{dc}	2000	1000	630	500	250	100	50	25	16	2000	1000	630	500	250	100	50	25	16	10	6.3	2000	1000	630	500	250	100	50	25	16	10	6.3	2000	1000	630	500	250	100	50	25	16	10	6.3			
224															*	*	*	*	*	*						*	*	*	*	*	*	*						*	*	*	*	*	*	*	
274																*	*	*	*	*	*						*	*	*	*	*	*	*						*	*	*	*	*	*	*
334																*	*	*	*	*	*						*	*	*	*	*	*	*						*	*	*	*	*	*	*
474																*	*	*	*	*	*						*	*	*	*	*	*	*						*	*	*	*	*	*	*
684																*	*	*	*	*	*						*	*	*	*	*	*	*						*	*	*	*	*	*	*
105																*	*	*	*	*	*						*	*	*	*	*	*	*						*	*	*	*	*	*	*
205																	*	*	*	*	*						*	*	*	*	*	*	*						*	*	*	*	*	*	*
225																	*	*	*	*	*						*	*	*	*	*	*	*						*	*	*	*	*	*	*
475																	*	*	*	*	*						*	*	*	*	*	*	*						*	*	*	*	*	*	*
106																	*	*	*	*	*						*	*	*	*	*	*	*						*	*	*	*	*	*	*
226																	*	*	*	*	*						*	*	*	*	*	*	*						*	*	*	*	*	*	*
476																	*	*	*	*	*						*	*	*	*	*	*	*						*	*	*	*	*	*	*

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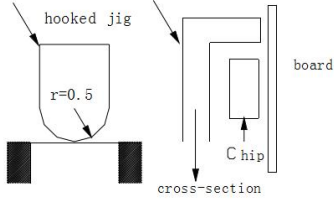
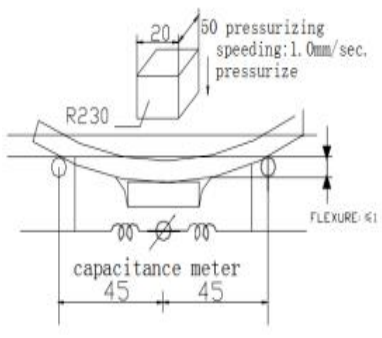
7.技术要求和测试条件 Specification and Test Condition>>>

NO	项目	类型 Dielectrics	技术要求 Specification				测试条件 Testing Condition	
1	容量 Capacitance	COG	在要求的容值容差范围内 Within the specified tolerance				1.0±0.2Vrms, 1MHz±10% (C>1000 pF, 1.0±0.2Vrms, 1KHz±10%)	
		X7R X7S X7T X5R X6R X6S X6T					1.0±0.2Vrms, 1KHz±10% (Cp > 10uF,0.5±0.1Vrms,120±24Hz)	
		备注 :测试温度 :25℃±3℃ ,测试湿度 : < 70%RH. 针对二类介质规格需去老化处理 ,条件 :电容器在 150+0/-10℃ 热处理 1 小时 , 放置 24±2h 后进行测量。						
2	损耗 Dissipation Factor	COG	Cp<30pF, Q≥400+20Cp; Cp≥30pF, Q≥1000				1.0±0.2Vrms,1MHz±10% ,25 ℃ (Cp>1000pF,1.0±0.2Vrms,1KHz±10%)	
		X7R X7S X7T X5R X6R X6S X6T	规格	U _R	容值范围	DF	1.0±0.2Vrms, 1KHz±10%, (Cp > 10uF,0.5±0.1Vrms, 120±24Hz)	
			0201	/	C≤0.01μF	≤7%		
					C > 0.01μF	≤10%		
			0402	≤25V	C≤0.47μF	≤7%		
					C > 0.47μF	≤10%		
				> 25V	C≤0.1μF	≤7%		
					C > 0.1μF	≤10%		
			0603	≤25V	C≤0.47μF	≤7%		
					C > 0.47μF	≤10%		
				> 25V	C≤0.1μF	≤5%		
					0.1μF < C≤0.22μF	≤7%		
					C > 0.22μF	≤10%		
			0805	≤25V	C≤1μF	≤7%		
					C > 1μF	≤10%		
				> 25V	C≤0.47μF	≤7%		
					C > 0.47μF	≤10%		
			1206	≤25V	C < 2.2μF	≤7%		
					2.2μF≤C < 47μF	≤10%		
				> 25V	C < 1μF	≤7%		
					1μF≤C < 47μF	≤10%		
			1210	/	C < 2.2μF	≤7%		
					2.2μF≤C < 47μF	≤10%		
			1812	/	C < 2.2μF	≤7%		
					2.2μF≤C < 47μF	≤10%		
			2220	/	C < 2.2μF	≤7%		
					2.2μF≤C < 47μF	≤10%		
			备注 :测试温度 :25℃±3℃ ,测试湿度 : < 70%RH. 针对二类介质规格需去老化处理 ,条件 :电容器在 150+0/-10℃ 热处理 1 小时 , 放置 24±2h 后进行测量。					

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NO	项目	类型 Dielectrics	技术要求 Specification	测试条件 Testing Condition				
3	耐电压 Dielectric Strength	COG	$U_R \leq 50V$	施加额定电压的 300%,5 秒,最大电流不超过 50mA Force 300%Rated voltage for 5second. Max..current should not exceed 50 mA.				
		X7R/X7S/ X7T/X5R /X6R/X6S/ X6T	$U_R \leq 50V$	施加额定电压的 250%,5 秒,最大电流不超过 50mA Force 250%Rated voltage for 5second. Max..current should not exceed 50 mA.				
		COG/X7R/ X7S/X7T/ X5R /X6R/ X6S/X6T/	$100V \leq U_R < 500V$	施加额定电压的 200%,5 秒,最大电流不超过 50mA Force 200%Rated voltage for 5second. Max..current should not exceed 50 mA.				
			$500V \leq U_R < 2000V$	施加额定电压的 150%,5 秒,最大电流不超过 50mA Force 150% Rated voltage for 5second. Max..current should not exceed 50 mA.				
			$U_R \geq 2000V$	施加额定电压的 120%,5 秒,最大电流不超过 30mA Force 120%Rated voltage for 5second. Max..current should not exceed 30 mA.				
4	静电容量温 度特性 Temperatur e Coefficient of Capacitance	COG	容量变化在 $\pm 30ppm/^{\circ}C$ 以内 容量漂移在 $\pm 0.2\%$ 或 $\pm 0.05pF$ 以内 Temperature coefficient within $\pm 30ppm/^{\circ}C$; Cp drift within $\pm 0.2\%$ or $\pm 0.05pF$	按系列温度顺序测试电容容量 Measure capacitance under follow table list temperature: 在 $140 \sim 150^{\circ}C$ 预处理 1 小时 ,放置 24h 后进行测量。				
		X7R/X5R X6R	容量变化在 $\pm 15\%$ 以内 Capacitance change within $\pm 15\%$	步骤	COG, X7R X7T	X6S	X5R	Y5V
				1	25 $\pm$ 2	25 $\pm$ 2	25 $\pm$ 2	25 $\pm$ 2
				2	-55 $\pm$ 3	-55 $\pm$ 3	-55 $\pm$ 3	-30 $\pm$ 3
				3	25 $\pm$ 2	25 $\pm$ 2	25 $\pm$ 2	25 $\pm$ 2
				4	125 $\pm$ 3	105 $\pm$ 3	85 $\pm$ 3	85 $\pm$ 3
		5	25 $\pm$ 2	25 $\pm$ 2	25 $\pm$ 2	25 $\pm$ 2		
		X7T/X6T	容量变化在+22%, -33%以内 Capacitance change within +22%, -33%	1) COG 容量漂移的计算方法为：用步骤 3 测量的电容容值量除以在第 1、3 和 5 步骤测量得到的误差的最大值和最小值的差。 温度系数的计算以第 3 步骤测量电容容量为参考。 The capacitance drift is calculated by dividing the differences between the maximum and minimum measured values in the step 1,3 and 5. The temperature coefficient is determined using the Capacitance measured in step 3 as a reference.				
X6S/X7S	容量变化在 $\pm 22\%$ 以内 Capacitance change within $\pm 22\%$	2)X7R、X7S、X7T、X5S、X6R、X6S、X6T 与 $25^{\circ}C$ 时的电容容量相比较，电容容量在温度范围内的变化在要求的范围之内。 X7R、X7S、X7T、X5S、X6R、X6S、X6T The ranges of capacitance change compared within the above $25^{\circ}C$ value over the temperature ranges shall be within the specified ranges.						
备注：0201/223 及以上规格、0402/104 及以上规格、0603/334 及以上规格、0805/105 及以上规格、1206/1210 225 及以上规格，测试电压： $< 0.5V$ 。								

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NO	项目	类型 Dielectrics	技术要求 Specification	测试条件 Testing Condition
5	绝缘电阻 Insulation Resistance	COG/X7R/ X7S/X7T/ X5R/X6R/ X6S/X6T/	$U_R \leq 50V$, 大于 $10 G\Omega$ 或 $100\Omega \cdot F / CR$ (大于其中较小的数值) $U_R \leq 50V$, More than $10 G\Omega$ or $100\Omega \cdot F / CR$, whichever is smaller.	$U_R \leq 50V$ $U_{测} = U_R$; 充电时间: 60 ± 5 秒 温度: $25^\circ C$ Charge Time: $60 \pm 5 \text{sec}$ Temperture: $25^\circ C$
		COG/X7R/ X7S/X7T/ X5R/X6R/ X6S/X6T/	$U_R > 50V$, 大于 $4 G\Omega$ 或 $100\Omega \cdot F / CR$ (大于其中较小的数值) $U_R > 50V$, More than $4 G\Omega$ or $100\Omega \cdot F / CR$, whichever is smaller.	$U_R \leq 400V$ $U_{测} = U_R$ $U_R > 400V$ $U = 400V$; 充电时间: 60 ± 5 秒 温度: $25^\circ C$ Charge Time: $60 \pm 5 \text{sec}$ Temperture: $25^\circ C$
		备注: 测试温度: $25^\circ C \pm 3^\circ C$, 测试湿度: $< 70\% RH$.		
6	附着力 Adhesion	COG/X7R/ X7S/X7T/ X5R /X6R/ X6S/X6T/	无可见损伤; 1.容值满足规格要求; 2.DF 满足初始值要求; 3.IR 满足初始值要求。 No remarkable visual damage. 1.Cp meets initial standard value. 2.DF meets initial standard value. 3.IR meets initial standard value.	片状电容器用回流焊焊接在 P.C 板上。施加 $17.7N$ (0402 规格产品施加 $6N$) 的力, 加力点在瓷体表面的中心位置, 即垂直于基片表面和平行于端面中心的连线。该力逐步地无冲击地施加在片状电容器本体上, 并保持 $10s \pm 1s$。 ($1.8Kgf = 17.7N$)。 Reflow solder the capacitors on a P.C.Board 。 Apply a pushing force gradually at the center of a specimen in a horizontal direction of P.C.board , Pushing force : $17.7N$ ($6N$ is applied for 0402 type) Holding time : $10 \pm 1s$. ($1.8Kgf = 17.7N$) 
7	端电极结合 强度 Bending	COG	无可见损伤; 容量变化小于等于 $\pm 5\%$ 或 $\pm 0.5pF$ (取较大值) No remarkable visual damage Cp change within $\pm 5.0\%$ or $\pm 0.5pF$, whichever is larger.	将片状电容器安装在测试夹具上, 按图所示方向以 $1.0mm/s$ 的速率施加压力, 弯曲 $2mm$。持续 $60s$。 Solder the capacitor on testing substrate and put it on testing stand. The middle part of substrate shall successively be pressurized by pressuring rod at a rated of about $1.0mm/sec$. Until the deflection become means of the $2.0mm$ for $60s$. 
		X7R/ X7S/X7T/ X5R /X6R/ X6S/X6T/	无可见损伤; 容量变化小于等于 $\pm 10\%$ No remarkable visual damage Cp change $\leq \pm 10\%$	

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NO	项目	类型 Dielectrics	技术要求 Specification	测试条件 Testing Condition		
8	耐焊接热 Resistance to Soldering Heat	COG	无明显可见损伤 容量变化在±2.5%或±0.25pF（取较大值）以内 DF 满足产品初始值的要求 IR 满足产品初始值的要求 No remarkable visual damage Cp change within ±2.5% or ±0.25pF, whichever is larger. DF meets initial standard value. IR meets initial standard value.	焊接温度: 270±5℃ 预热: 120~150℃ 60 秒 浸入时间: 10±1 秒 在 室 温 下 放 置 24±2 (COG) 或 48±4(X7R/X7S/X7T/X5R/X6R/X6S/X6T) 小时以后 测量 试验后在标准条件下恢复 *高介电常数电容器的初始值测量 在 140~150℃进行 1 小时的热处理后在室温下 放置 48±4 小时 测量初始值 Soldering temperature: 270±5℃ Preheating: 120~150℃ 60sec. Dipping time: 10±1 seconds. Measurement to be made after being kept at room temperature for 24±2 (COG) or 48±4(X7R/X7S/X7T/X5R/X6R/X6S/X6T) hours. Recov ery for the following period under the standard condition after test. *Initial measurement for high dielectric constant type Perform a heat treatment at 140~150℃ for 1hr and let sit for 48±4hrs at room temperature. Perform the initial measurement.		
		X7R/ X7S/X7T/ X5R /X6R/ X6S/X6T/	无明显可见损伤 容量变化在±7.5%以内 DF 满足产品初始值的要求 IR 满足产品初始值的要求 No remarkable visual damage Cp change within ±7.5% DF meets initial standard value. IR meets initial standard value.			
9	温度快速循环 Temperatur e Cycle	COG	无明显可见损伤 容量变化在±2.5%或 ±0.25pF（取较大值）以内 No remarkable visual damage Cp change within ±2.5% or ±0.25pF, whichever is larger.	按下列步骤进行 5 次循环： To perform 5 cycles of the stated environment		
				步 骤	温度 Temperature	时间 Time
				1	下限类别温度+0/-3℃	30min
				2	25℃	2~3 min
				3	上限类别温度+3/-0℃	30min
		4	25℃	2~3 min		
X7R/ X7S/X7T/ X5R /X6R/ X6S/X6T/	无明显可见损伤 容量变化在±7.5%以内 No remarkable visual damage Cp change within ±7.5%	切换时间不超过 1min。 在 室 温 下 放 置 24±2 (COG) 或 48±4(X7R/X7S/X7T/X5R/X6R/X6S/X6T) 小时以后 测量 Measurement to be made after being kept at room temperature for 24±2hrs (COG) or 48±4hrs (X7R/X7S/X7T/X5R /X6R/X6S/X6T)				

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NO	项目	类型 Dielectrics	技术要求 Specification	测试条件 Testing Condition
10	稳态湿热 Moisture Resistance ,s steady state	COG	外观无明显可见损伤 1.容量变化在 $\pm 5\%$ 或 $\pm 0.5\text{pF}$ (取较大值) 以内 2. $C_p < 10\text{pF}$, $Q \geq 200 + 10C_p$; $10 \leq C_p < 30\text{pF}$, $Q \geq 275 + 2.5C_p$ $C_p \geq 30\text{pF}$, $Q \geq 350$ 3.IR: 大于 $1000\text{M}\Omega$ 或 $10\Omega \cdot \text{F}$ (取较小值) No remarkable visual damage 1.Cp change within $\pm 5\%$ or $\pm 0.5\text{pF}$, whichever is larger. 2. $C_p < 10\text{pF}$, $Q \geq 200 + 10C_p$; $10 \leq C_p < 30\text{pF}$, $Q \geq 275 + 2.5C_p$ $C_p \geq 30\text{pF}$, $Q \geq 350$ 3.IR: $\geq 1000\text{M}\Omega$ or $R \cdot C \geq 10\Omega \cdot \text{F}$, whichever is smaller	测试温度: $40 \pm 2^\circ\text{C}$ 湿度: $90 \sim 95\% \text{ RH}$ 测试时间: $500 \pm 12\text{hrs}$ 在室温下放置 24 ± 2 (COG) 或 48 ± 4 (X7R/X7S/X7T/X5R/X6R/X6S/ X6T) 小时以后 测量 *高介电常数电容器的初始值测量在 $140 \sim 150^\circ\text{C}$ 进行 1 小时的热处理后在室温下放置 48 ± 4 小 时 测量初始值 Test temperature: $40 \pm 2^\circ\text{C}$ Humidity: $90 \sim 95\% \text{ RH}$ Testing time: $500 \pm 12\text{hrs}$ Measurement to be made after being kept at room temperature for $24 \pm 2\text{hrs}$ (COG) or $48 \pm 4\text{hrs}$ (X7R/X7S/X7T/X5R/X6R/X6S/X6T) *Initial measurement for high dielectric constant type Perform a heat treatment at $140 \sim 150^\circ\text{C}$ for 1hr and let sit for $48 \pm 4\text{hrs}$ at room temperature. Perform the initial measurement
		X7R/ X7S/X7T/ X5R /X6R/ X6S/X6T/	外观无明显可见损伤 1.容量变化在 $\pm 12.5\%$ 以内 2.DF 为初始值的 2 倍以下 3.IR:大于 $1000\text{M}\Omega$ 或 $10\Omega \cdot \text{F}$ (取较小值) No remarkable visual damage 1.Cp change within $\pm 12.5\%$ 2.DF:Not more than 2 times of initial value 3. IR: $\geq 1000\text{M}\Omega$ or $R \cdot C \geq 10\Omega \cdot \text{F}$, whichever is smaller	
11	耐湿负荷 Damp heat with load	COG	外观无明显可见损伤 容量变化在 $\pm 7.5\%$ 或 $\pm 0.75\text{pF}$ (取较大值) 以内 $C_p < 30\text{pF}$, $Q \geq 100 + 10/3 \cdot C_p$ $C_p \geq 30\text{pF}$, $Q \geq 200$ IR: 大于 $500\text{M}\Omega$ 或 $5\Omega \cdot \text{F}$ (取较小值) No remarkable visual damage Cp change $\leq \pm 7.5\%$ or $\pm 0.75\text{pF}$, whichever is larger. $C_p < 30\text{pF}$, $Q \geq 100 + 10/3 \cdot C_p$ $C_p \geq 30\text{pF}$, $Q \geq 200$ $R \cdot C \geq 500\text{M}\Omega$ or $5\Omega \cdot \text{F}$, whichever is smaller	测试温度: $85 \pm 2^\circ\text{C}$ 湿度: $85\% \text{ RH}$ 电压: 额定电压和 1.5V 充电和工作电流: $\leq 50\text{mA}$ 测试时间: $1000 \pm 48\text{hrs}$ 在室温下放置 24 ± 2 (COG) 或 (X7R/X7S/X7T/X5R/X6R/X6S/X6T) 150°C 、1h 预处 理后, 放置 48 ± 4 小时以后测量 *在 150°C 、1h 预处理后, 在室温下放置 48 ± 4 (X7R/X7S/X7T/X5R /X6R/X6S/X6T) 小时后; 测量初始电容值。 Test temp. : $85 \pm 2^\circ\text{C}$ Test humidity : $85\% \text{ RH}$ Applied voltage : Rated voltage and 1.5V Test time : $1000 \pm 48\text{h}$ Charge/discharge current : 50mA or lower Leave the capacitors in ambient condition for Class 1 : $24 \pm 2\text{h}$ Leave the capacitors in ambient condition for Class 2 : $48 \pm 4\text{h}$ before measurement. Reflow solder the capacitors on a P.C.Board shown in Appendix2 before testing. Perform the initial measurement.
		X7R/ X7S/X7T/ X5R /X6R/ X6S/X6T/	外观无明显可见损伤 容量变化在 $\pm 12.5\%$ 以内 DF 为初始值的 2 倍以下 IR: 大于 $500\text{M}\Omega$ 或 $5\Omega \cdot \text{F}$ (取较小值) No remarkable visual damage Cp change $\leq \pm 12.5\%$ DF:Not more than 2 times of initial value $R \cdot C \geq 500\text{M}\Omega$ or $5\Omega \cdot \text{F}$, whichever is smaller	

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NO	项目	类型 Dielectrics	技术要求 Specification	测试条件 Testing Condition
12	耐焊性 Resistance to leaching	COG/X7R/ X7S/X7T/ X5R /X6R/ X6S/X6T/	端电极挂锡面积不小于 95%，针孔或粗糙面积 小于 5%，外观无开裂 95% min. coverage of both terminalelectrodes and less than 5% have pinholes or rough spots. No remarkable visual damage.	预热：120℃~150℃/60 秒锡炉温度：270±5℃ 浸入时间：10±1 秒 两侧端电极完全浸入焊锡炉 Solder temperature: 270±5℃ preheated: 120℃~150℃/60sec Dipping time: 10±1 seconds. Completely soak both terminal electrodes in solder
13	可 焊 性 Solderability of Termination	COG/X7R/ X7S/X7T/ X5R /X6R/ X6S/X6T/	端电极挂锡面积不小于 95%，针孔或粗糙面积 小于 5% 95% min. coverage of both terminal electrodes and less than 5% have pin holes or rough spots.	锡炉温度：245±5℃ 浸入时间：2±1 秒 两侧端电极完全浸入焊锡炉 Solder temperature: 245±5℃ Dipping time: 2±1 seconds. Completely soak both terminal electrodes in solder
14	耐久性 Life Test	COG	外观无明显可见损伤 1.容量变化在±5%或±0.5pF（取较大值）以内 2.容量在 30pF 以上，Q≥350 容 量 在 10pF 以上且小于 30 pF， Q≥275+(2.5* Cp) 容量小于 10pF,Q≥200+10*Cp 3.IR:大于 1000MΩ或 5Ω·F(取较小值) No remarkable visual damage 1. Cp changes±5% or ±0.5pF, whichever is larger. 2. Q≥350 (Cp≥30 pF) Q≥275+(2.5* Cp) (10 pF≤Cp<30 pF) Q≥200+10*Cp (Cp<10 pF) 3. IR:≥1000MΩ or R*C≥5Ω·F, whichever is smaller	测试温度：上限类别温度±3℃ 电压：UR < 100V 1.5 倍额定电压（*见备注） 测试时间: 1000 小时 在室温下放置 24±2 (COG) 或 (X7R/X7S/X7T/X5R/X6R/X6S/X6T)：150℃、 1h 预处理后，放置 48±4 小时以后测量 * 在 150℃、1h 预 处 理 后， 48±4(X7R/X7S/X7T/X5R/X6R/X6S/X6T) 小时以后；测量初始电容值。 Test temperature: Max. Operating Temp. ±3℃ Voltage: UR < 100V 150%of the rated voltag（*Remarks） Testing time: 1000 hrs Measurement to be made after being kept at room temperature for 24±2hrs (COG) or 48±4hrs (X7R/X7S/X7T/X5R/X6R/X6S/X6T) *Initial measurement for high dielectric constant type Apply 150% of the rated DC voltage for one hour at the maximum operating temperature ±3℃. Remove and let sit for 48±4hrs at room temperature. Perform the initial measurement
		X7R/ X7S/X7T/ X5R /X6R/ X6S/X6T/	外观无明显可见损伤 1.容量变化在±12.5%以内 2.DF 为初始值的 2 倍以下 3.IR:大于 1000MΩ或 5Ω·F(取较小值) No remarkable visual damage 1. Cp changes±12.5% 2.DF:Not more than 2 times of initial value 3. IR:≥1000MΩ or R*C≥5Ω·F whichever is smaller	
15	高温存储 High-temper ature storage	COG/X7R/ X7S/X7T/ X5R /X6R/ X6S/X6T/	无可见损伤； 1. 容值变化率： COG: ±5%或±0.5pF 以内，取较大值； X7R/X7S/X7T/X5R/X6R/X6S/X6T: ±10 %以内； 2.DF：满足初始值要求； 3.IR：满足初始值要求。 No remarkable visual damage； 1. Rate of change of capacity value： COG：±5% or ±0.5pF，take a larger value； X7R/X7S/X7T/X5R/X6R/X6S/X6T: Within ±10 %； 2.DF：Satisfy the initial value requirement. 3.IR：Satisfy the initial value requirement.	在最大额度温度下放置产品 1000 小时。 试验结束后 24±4 小时内进行测试。 Keep the product at maximum temperature for 1000 hours. The test was carried out within 24±4 hours after the end of the test.

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NO	项目	类型 Dielectrics	技术要求 Specification	测试条件 Testing Condition
16	静电测试 ESD	COG/X7R/ X7S/X7T/ X5R /X6R/ X6S/X6T/	1.容值变化率： COG/M3L: $\pm 5\%$或$\pm 0.5\text{pF}$ 以内，取较大值； X7R/X7S/X7T/X5R/X6R/X6S/X6T: $\pm 10\%$以内； 2.DF：满足初始值要求； 3.IR：满足初始值要求。 1. Rate of change of capacity value : COG/M3L:Cp change within $\pm 5\%$ or $\pm 0.5\text{pF}$, whichever is larger; X7R/X7S/X7T/X5R/X6R/X6S/X6T: Cp change within $\pm 10\%$; 2.DF meets initial standard value. 3.IR meets initial standard value.	参考 AEC-Q200-002 Per AEC-Q200-002
17	破坏性物理 分析 DPA	COG/X7R/ X7S/X7T/ X5R /X6R/ X6S/X6T/	确认产品内部设计是否存在缺陷： 电极连续性良好、电极厚度一致、内外电极连接良好、上下盖片厚度一致 Confirm whether there are defects in the internal design of the product : good electrode continuity、uniform electrode thickness 、 good connection of internal and external electrodes、 same thickness of upper and lower covers	样品侧面研磨 LT 面 Sample LT side grinding
18	温度冲击 Temperature shock	COG/X7R/ X7S/X7T/ X5R /X6R/ X6S/X6T/	无明显可见损伤； 1 . 容值变化率： COG: $\pm 5\%$或$\pm 0.5\text{pF}$ 以内，取较大值； X7R/X7S/X7T/X5R/X6R/X6S/X6T: $\pm 10\%$以内； 2.DF：满足初始值要求； 3.IR：满足初始值要求。 No remarkable visual damage ; 1 . Rate of change of capacity value : COG : $\pm 5\%$ or $\pm 0.5\text{pF}$, take a larger value ; X7R/X7S/X7T/X5R /X6R/X6S/X6T: Within $\pm 10\%$; 2.DF : Satisfy the initial value requirement. 3.IR : Satisfy the initial value requirement.	将安装的电容器放入试验箱内，按下列步骤进行 1000 次循环： -55℃ (30min) →125℃ (30min) 切换时间不超过 1min。 COG 类： 在室温下放置 6h~24h 小时以后测量； X7R/X7S/X7T/X5R /X6R/X6S/X6T: 在室温下放置 24±2 小时以后测量： Put the installed capacitor into the test chamber and cycle 1000 times according to the following steps : -55℃ (30min) →125℃ (30min) , the switching time should not exceed 1 minute. COG: Measurement to be made after being kept at room temperature for 6h~24hrs X7R/X7S/X7T/X5R /X6R/X6S/X6T: Measurement to be made after being kept at room temperature for 24±2hrs
19	振动实验 Vibration	COG/X7R/ X7S/X7T/ X5R /X6R/ X6S/X6T/	无明显可见损伤； 1.COG 材质：容量变化在$\pm 5\%$或 $\pm 0.5\text{pF}$ (取较大值) 以内； X7R/X7S/X7T/X5R/X6R/X6S/X6T 材质容值变化率在$\pm 10\%$以内； 2.DF：满足初始值要求； 3.IR：满足初始值要求。 No remarkable visual damage 1.COG:Cp change within $\pm 5\%$ or $\pm 0.5\text{pF}$, whichever is larger. X7R/X7S/X7T/X5R/X6R/X6S/X6T change within $\pm 10\%$; 2.DF meets initial standard value. 3.IR meets initial standard value.	在实验前先将产品用回流焊焊接在 P.C 板上。 施加力：$\leq 5\text{g/s}$； 频率：$10\sim 2000\text{Hz}$ 循环周期：20min 循环次数：三个方向每个方向 12 个循环 Reflow solder the capacitors on a P.C.Board shown in Appendix 2 before testing 。 Applied force : 5G max. Frequency : $10\sim 2,000\text{Hz}$ Reciprocating sweep time : 20 min. Cycle : 12 cycles in each 3 mutually perpendicular directions.

| 汽车级多层片式瓷介电容器

NO	项目	类型 Dielectrics	技术要求 Specification	测试条件 Testing Condition
20	抗折强度 Rupture strength	COG/X7R/ X7S/X7T/ X5R /X6R/ X6S/X6T/	0402 $\geq$ 1.2Kgf、 0603 $\geq$ 3.0Kgf、 0805 ($\leq$ 0.85mm) $\geq$ 4.0kgf、 0805 (1.25mm) $\geq$ 7.0Kgf、 1206 (< 1.25mm) $\geq$ 4.0Kgf 1206 ($\geq$ 1.25mm) $\geq$ 6.0Kgf	将片状电容器固定在测试模具上，使用拉力测试仪施加 1mm/s 的压力至电容器断裂 Attach the chip capacitor to the test die and apply 1mm/s of pressure using a tension tester until the capacitor breaks.
21	机械冲击 Mechanical impact	COG/X7R/ X7S/X7T/ X5R /X6R/ X6S/X6T/	无明显可见损伤； 1.COG 材质：容量变化在 $\pm 5\%$ 或 $\pm 0.5\text{pF}$ （取较大值）以内； X7R/X7S/X7T/X5R /X6R/X6S/X6T 材质容量变化率在 $\pm 10\%$ 以内； 2.DF：满足初始值要求； 3.IR：满足初始值要求。 No remarkable visual damage 1. COG: Cp change within $\pm 5\%$ or $\pm 0.5\text{pF}$, whichever is larger. X7R/X7S/X7T/X5R /X6R/X6S/X6T change within $\pm 10\%$; 2.DF meets initial standard value. 3.IR meets initial standard value.	将片状电容器固定在拉力测试仪上，从 XYZ 三个方向冲击， 脉冲信号：半正弦脉冲 持续时间：0.5ms 峰值加速度：1500g Fix the flake capacitor on the tension tester, impact from three directions XYZ, Pulse signal: half sinusoidal pulse Time of duration: 0.5ms Peak acceleration: 1500g

8.MLCC 使用注意事项 Precautions on the use of MLCC>>>

8.1 电路板设计 PCB Design

8.1.1 电路板图案设计 Design of Land-patterns

下面图和表格给出了部分推荐的设计图案，可以防止安装时焊锡量过多。

同时也给出了不正确的图案。

The following diagrams and tables show some examples recommended patterns to prevent excessive solder amounts (larger fillets which above the component end terminations)

Examples of improper pattern designs are also shown.

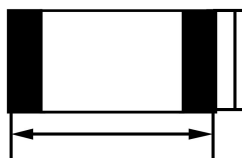
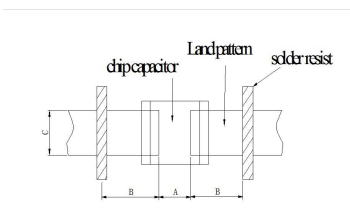
电路板设计推荐图案尺寸：

Recommended land dimensions for a typical chip capacitor land patterns for PCBs

波峰焊接时推荐设计的尺寸 (单位: mm)：

Recommended land dimensions for wave-soldering (unit: mm)

规格 SIZE		0603	0805	1206
尺寸	L	1.6	2.0	3.2
	W	0.8	1.25	1.6
A		0.8~1.0	1.0~1.4	1.8~2.5
B		0.5~0.8	0.8~1.5	0.8~1.7
C		0.6~0.8	0.9~1.2	1.2~1.6



再流焊接时推荐设计的尺寸 (单位: mm)

Recommended land dimensions for reflow-soldering (unit: mm)

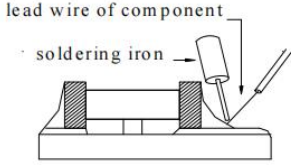
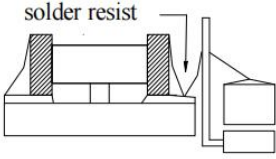
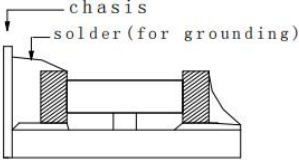
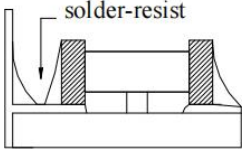
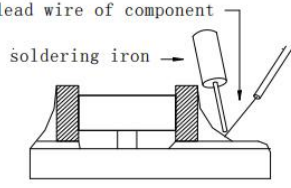
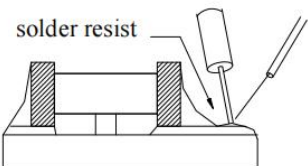
规格 SIZE		0201	0402	0603	0805	1206	1210	1812	2220
尺寸	L	0.6	1.0	1.6	2.00	3.2	3.2	4.5	5.7
	W	0.3	0.5	0.8	1.25	1.6	2.5	3.2	5.0
A		0.20~0.25	0.35~0.45	0.6~0.8	0.8~1.2	1.8~2.5	1.8~2.5	2.5~3.4	4.0~4.6
B		0.20~0.30	0.40~0.50	0.6~0.8	0.8~1.2	1.0~1.5	1.0~1.5	1.8~2.0	2.0~2.2
C		0.25~0.35	0.45~0.55	0.6~0.8	0.9~1.6	1.2~2.0	1.6~3.2	2.3~3.5	3.5~4.8

过量的焊锡会影响产品抵抗机械应力的能力，因此在设计图案时应引起注意。

Excess solder can affect the ability of chips to withstand mechanical stresses. Therefore, please take proper precautions when designing land-patterns.

在应用中一些焊接好与坏的情况：

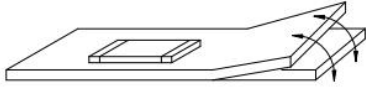
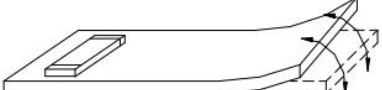
Examples of good and bad solder application

项目 Item	不推荐结构 Not recommended	推荐结构 Recommended
片状元件和带引线的元件的混合焊接 Mixed mounting of SMD and leaded component		
靠近底座的焊接 Component placement close to the chassis		
在片状元件附近带引线元件的焊接 Hand-soldering of leaded components near mounted components		

8.1.2 图案结构 Pattern configurations

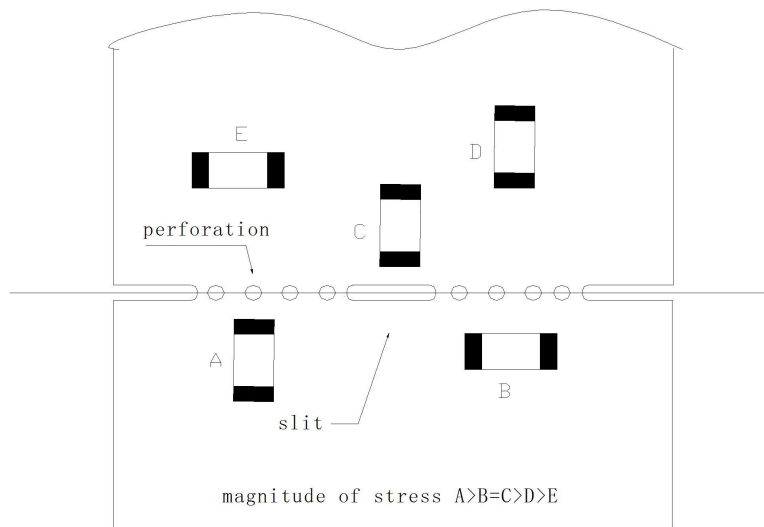
下面是电容器安装好与坏例子。选择贴装位置，应尽可能减小电路板在弯曲时受到的机械应力。

The following are examples of good and bad capacitor layout, SMD capacitors should be located to minimize any possible mechanical stresses from board warp or deflection.

	不推荐结构 Not recommended	推荐结构 Recommended
电路板弯曲 Deflection of the board		

对于电路板分拨的电容器，在分拨时受到的机械应力大小与电容器的安装有关。下面推荐了一些好的设计。

To layout the capacitors for the breakaway PC board, it should be noted that the amount of mechanical stresses given depending on capacitor layout. The example below shows recommendations for better design.



在沿着分拨线分拨电路板时，对产品施加的机械应力与使用的方法关系很大。分折电路板时片状元件受到的疲劳按照如下顺序增大：分折、剪切、V 型槽、穿孔。因此，贴装时应该考虑电路板的分拨过程。

When breaking PC boards along their perforations, the amount of mechanical stress on the capacitors can vary according to the method used. The following methods are listed in order from least stressful to most stressful: push-back, silt, -grooving, and perforation. Thus, any ideal SMD capacitor layout must also consider the PCB splitting procedure.

8.2 自动贴装注意事项 Considerations for automatic placement

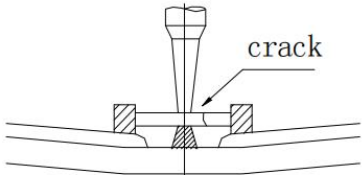
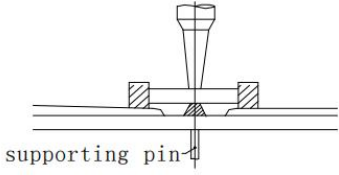
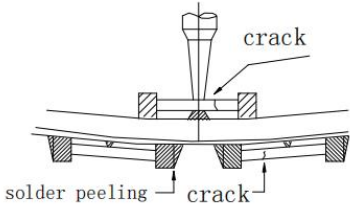
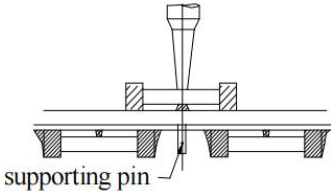
贴装机的调整 Adjustment of mounting machine

①. 产品在电路板贴装时，不应该受到过大的冲击。

②. 必须定期对吸头和定位爪进行检查、维修和更换

①. Excessive impact load should not be imposed on the capacitors when mounting the PC boards.

②. The maintenance and inspection of the mounters should be conducted periodically.

	不推荐结构 Not recommended	推荐结构 Recommended
单面贴装 Single-sided mounting		
双面贴装 Double-sided mounting		

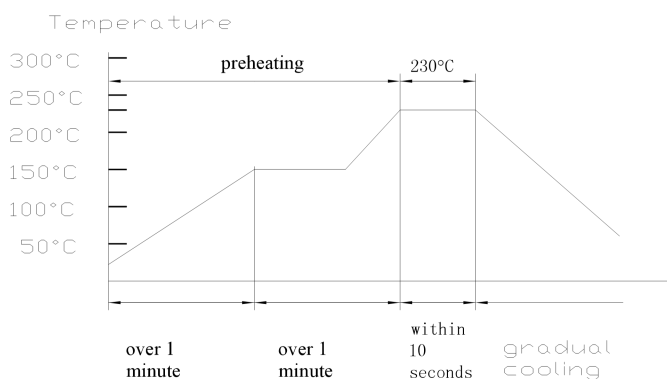
8.3 推荐焊接曲线 Recommended soldering profile

8.3.1 说明：① 产品推荐使用回流焊接工艺；② 大尺寸产品适用于回流焊接工艺

Re：①flow Soldering is recommended；②flow soldering is suitable for bigger size MLCCs

8.3.2 锡铅焊接曲线 Recommended Sn&Pb soldering profile

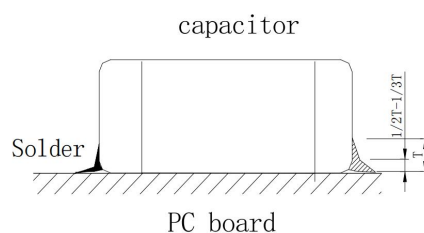
回流焊 Reflow soldering



注意 Caution

1. 理想状况的焊锡高度为电容器厚度的 $1/3 \sim 1/2$ ，如下图所示：

①.The ideal condition is to have solder mass (fillet) controlled to $1/2$ to $1/3$ of the thickness of the capacitor, as shown below:

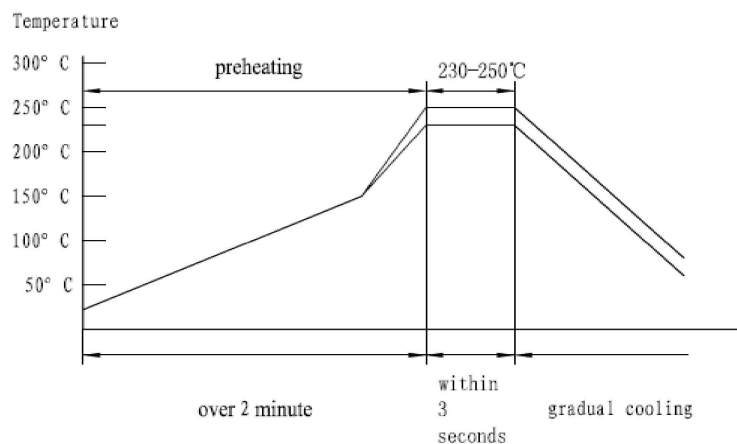


②. 过长的焊接时间会影响端头的可焊性，焊接时间尽可能保持与推荐时间一致。

②. Because excessive dwell times can detrimentally affect solderability, soldering duration should be kept as close to recommended times as possible.

波峰焊

Wave solder profile



| 汽车级多层片式瓷介电容器

注意 Caution

- ①.确保电容器充分预热。
- ②.产品预热和焊接温度差不超过 100~130℃。
- ③.焊接后尽可能慢速冷却。
- ①.Make sure the capacitors are preheated sufficiently.
- ②.The temperature difference between the capacitor and melted solder should not be greater than 100 to 130℃.
- ③. Cooling after soldering should be gradual as possible.

手工焊接 Hand soldering

条件:

预热	烙铁头温度	烙铁功率	烙铁头直径	焊接时间	锡膏量	限制条件
$\Delta \leq 130^{\circ}\text{C}$	最高350℃	最大20W	建议1mm	最长5s	$\leq 1/2$ 芯片厚度	请勿使用烙铁头直接接触陶瓷原件

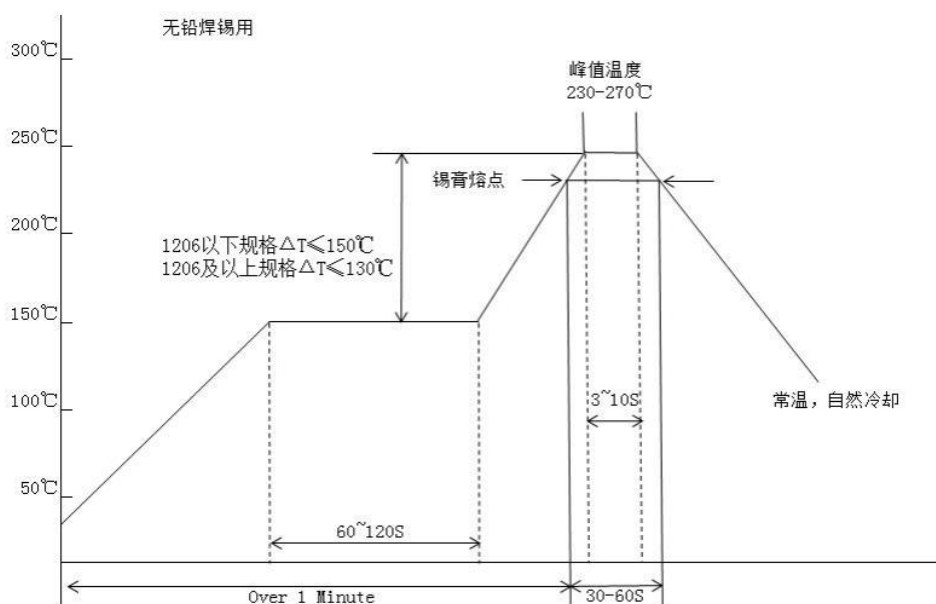
注意 Caution

- ①.用尖端最大直径 1.0mm 功率 20W 的焊接烙铁。
- ②.焊接烙铁不要直接接触产品。
- ①.Use a 20w soldering iron with a maximum tip diameter of 1.0mm.
- ②.The soldering iron should not directly touch the capacitor.

8.3.3 无铅焊接曲线 Recommended Pb-Free soldering profile

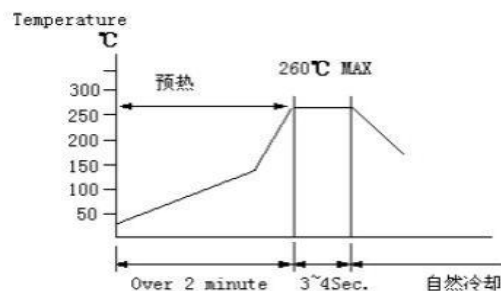
回流焊接

Reflow solder



波峰焊接

Wave solder profile



8.4 分拨电路板 Handling

Breakaway PC boards (splitting along perforations)

- (1).在电容器或其它贴装后，必须注意因电路板弯曲或变形带来的应力。
- (2).分拨电路板时必须使用专用的夹具，不可以用手拨断。

- (1).When splitting the PC board after mounting capacitors and other components, care is required so as not to give any stresses of deflection or twisting to the board.
- (2).Board separation should not be done manually, but by using the appropriate devices.

8.5 保存 Storage

- (1).在下列环境中保存产品：温度 5~40℃；湿度 ≤70% RH
 - (2).产品自生产之日保存期为一年，产品使用之前请勿拆开编带。
 - (3).编带拆开后，产品应在三个月内使用。
 - (4).高介电常数电容器 (X7R,X5R,Y5V、X7T、X6S) 的容值随时间会逐渐减小，所以在电路设计时应充分考虑这一现象。容值减小的电容器在 150℃热处理 1 小时后容值会恢复到初始值。
- (1). Keep the storage environment conditions as following: Temperature: 5~40℃；Humidity: ≤70% RH
 - (2). Don't open the tape until the parts are to be used, and store them within one year since the date printed on the reel.
 - (3). Use the chips within 3 months after the tape is opened.
 - (4). The capacitance value of high dielectric constant capacitors (X7R,X5R,Y5V、X7T、X6S) will gradually decrease with the passage of time, so this should be taken into consideration in the circuit design. If such a capacitance reduction occurs, a heat treatment of 150℃ for 1 hour will return the capacitance to its initial level.